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FORT PTO-1449 (modified)				Atty. Docket	Atty. Docket No. Serial No.			
List of Patents and Publications for Applicant's				2000.110600/	DE0347	10/790,	10/790,852	
				Applicant	Karsten Wieczorek, Thomas Feudel, Thorsten Kamml			
INF	ORMATIO	N DISCLOSURE ST	ATEMENT	and Wolfgang	Buchnoitz	- - - - - - - - - - 		
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Init.	Des.	Number				Class	Yes/No	
	B1							
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EXAMINER: DATE CONSIDERED: 12/10/19

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Atty. Docket No. 2000.110600/DE0347 Serial No. 10/790,852

List of Patents and Publications 100

Applicant Karsten Wieczorek, Thomas Feudel, Thorsten Kammler and Wolfgang Buchholtz

INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)

Filing Date: March 2, 2004 Group: 2811

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	C3	

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